

样品规格承认书

SAMPLE APPROVAL SHEET

客户 (Customer): _____

客户项目名称: (N0): _____

产品品名 (Description): 200 万 AF(1080P)摄像头

内部型号 (Model) : LCKFB-GC20x3-200W-MIPI-AF-V1-GC2093

样品确认 (Approval) : _____

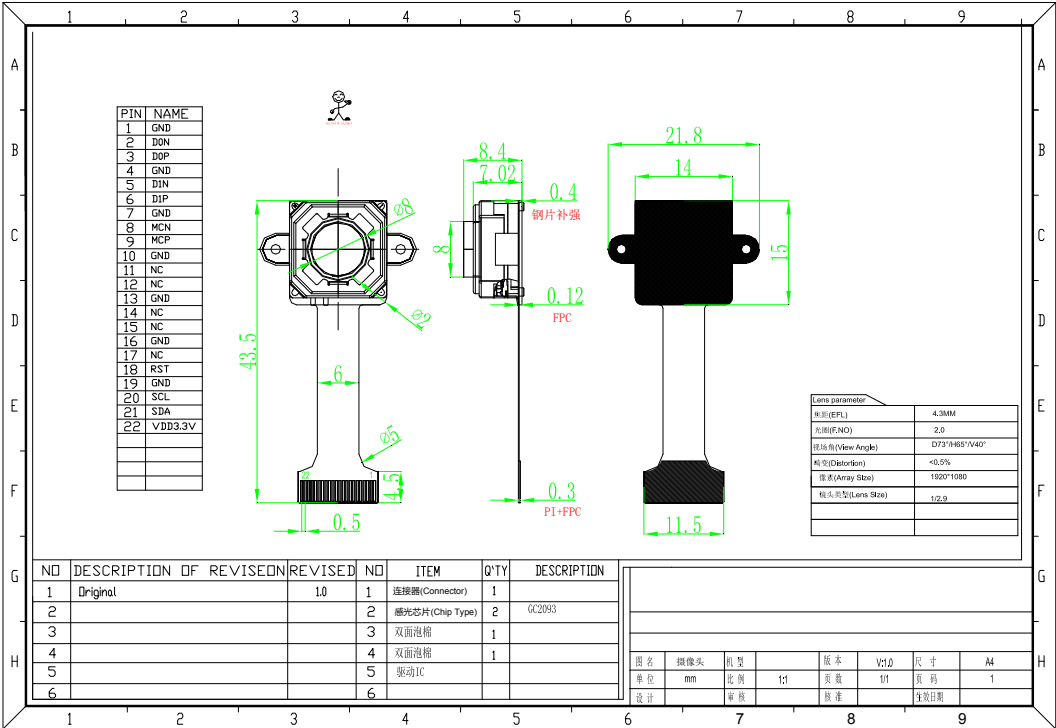
	单位	制作	市场部	工程部	审核
	签章				

客户 回签	单位	开拓组	外观结构	电子科	批准
	签章				

1. Key Specifications(主要规格)

Module No.	
Module Size:	43.3mm
Sensor Type :	GC2093
Lens Construction :	1/2.9"
Active pixel array	1920x1080
power supply:	core:1.15V~1.3V(1.2V normal)
	analog:2.7V~2.9V(2.8V normal)
	I/O:1.7V ~2.8V(1.8V normal)
Input clock frequency:	6~27 MHz
ADC resolution	10 bit ADC
Max Frame rate	60fps@full size
Power Consumption	TBD
MAX SNR	38dB
Operating temperature:	-30-85℃
Stable Image temperature	0-60℃
Storage temperature	-40-125℃
Pixel size:	2.8μmx2.8μm
Package type	CSP

4. Connector Pin Assignment (连接器Pin脚说明)



5. Appearance Specification (外观规格)

外观				
序号	项目	要 求	检验方法	不合格分类
1	模组外观	模组表面无脏污、无肉眼可见划伤, 塑胶内无杂质	8X放大镜	A
2	镜片	在 800 ± 100 Lux强度的光下平视、45度反射光检查时,不可有肉眼可见伤痕或脏污	8X放大镜	A
3	螺纹胶	点胶长度为周长的1/3-1/2, 胶不可溢到镜头端面 and 镜头底座	8X放大镜	A
4	密封胶	在底座与FPC之间均匀充满密封胶, 不可有间隙、无厚薄不均的现象,不可有胶溢出FPC边缘导致外形尺寸超标的现象	8X放大镜	A
5	柔板(FPC)	1) 表面无脏污、印刷字体清晰; 2) 边缘毛刺长度小于1mm, 宽度小于0.3mm; 3) 边缘缺口长度小于1mm, 宽度小于0.1mm每棱边不多于2处, 不许有向内撕裂状尖角	45 X显微镜 (连续变焦)	A
6	连接器	1) 外观不可有异物附着、油污、变色等缺陷; 2) 不允许有缺锡、少锡现象, 不允许有连焊现象; 3) PIN脚光亮、平整, 不允许有翘起现象	45 X显微镜 (连续变焦)	A
7	补强钢板	1) 表面不可有脏污、生锈、有触感划痕; 2) 定位柱超出板面高度 ≤ 0.1 mm	目视	B
外型尺寸				
序号	项目	要 求	检验方法	不合格分类
1	高度	符合图纸要求	数显卡尺	A
2	长度	符合图纸要求	数显卡尺	A
3	宽度	符合图纸要求	数显卡尺	A

6. Image Specification (图像规格)

光学性能检验要求				
序号	检验项目	要求	检验方法	不合格分类
1	污点(Dust)	白场下, 获取图像,目测全画面不允许有可见异物存在	测试夹具.小灯箱.6500K白色背光	A
2	成像方向(imaging direction)	符合图纸要求	测试夹具	A
3	坏点与集束型坏点(Dead & Wound Pixel)	不允许出现黑点/彩色点及闪烁亮点.	测试软件 小灯箱 (6500K白色背光)	A
4	分辨率 (Resolution)	CIF--中心 100 TV LINE VGA—中心 300 TV LINE,四周 250 TV LINE 2M—中心 800 TV LINE,四周 650 TV LINE 3M--中心 1000 TV LINE,四周 800 TV LINE 5M--中心 1200 TV LINE,四周 1000 TV LINE	MTF测试程序	A
5	视场角(FOV)	水平(horizontal):垂直(Vertical): 对角线(Diagonal):	测试夹具、 视场角标板	A
6	像面均匀度(相对照度)(Shading)	四角距离中心90 %处取样,要求其亮度值与中心处取样框亮度的比值大于60 % (取样框大小为40*40 像素, sensor 暗角补偿功能未开启)。	测试软件、 小灯箱 (3400Lux, 6500K 白色背光)	A
7	色差(Color difference)	对色彩图卡中的色块平均还原误差不大于20%	Color checker card	A
8	几何失(TVdistortion)	枕形失真(正数)或桶形失真(负数)均不大于1%	ISO12233标板	A
9	灰阶 (Grayscale)	相邻可分辨的两灰阶亮度差值必须小于8	测试软件、灰阶标板	A
10	色散(CA)	小于0.5	ISO12233标板	A
11	螺纹扭(Torsional)	不小于1 kgf.cm	扭力扳手	A
12	底座推力(Thrust)	不小于2 N	推力计	A

不合格品分类的说明: a) 严重不合格: 经检验判定的批量不合格, 或造成较大经济损失、直接影响产品质量、主要功能、性能技术指标等的不合格,用字母A表示;

b) 一般不合格:一般不合格是指能够同时满足下列条件的不合格品, 用字母B表示。

I) 不影响最终产品的外观质量;

II) 不影响最终产品的技术性能;

III) 原材料或最终产品不影响下道工序的加工或组装。

7. Sample Plan (抽样计划)

序号.	检验项目	抽样频率	检验方法	备注
成像和可靠性项目				
1	污点	每批N=5, C=0	与生产相同	生产全检项目
2	成像方向	每批N=5, C=0	测试夹具	生产全检项目
3	坏点与集束型坏点	每批N=5, C=0	与生产相同	生产全检项目
4	分辨率	每批N=5, C=0	MTF测试程序	生产全检项目
5	视场角	每批N=5, C=0	测试夹具、 视场角标板	样品阶段全检评估项目 QA抽检项目
6	像面均匀度	每批N=5, C=0	测试软件, 小灯箱 3400Lux, 6500K白色背光	生产全检项目
7	色散	每批N=5, C=0	测试软、Colorcheckercard	样品阶段全检评估项目 QA抽检项目
8	几何失真	每批N=5, C=0	测试软件、ISO1223 3标板	样品阶段全检评估项目 QA抽检项目
9	灰阶	每批N=5, C=0	测试软件、 灰阶标板	样品阶段全检评估项目 QA抽检项目
10	可靠性试验	样品试制阶段:抽样计划: 2PCS/每生产批次, 允收水准0/1 生产稳定阶段:抽样计划: 每项目5PCS /每月, 允收水准0/1		
外观项目				
1	模组外观	AQL=1.0	8 X放大镜	生产全检项目
2	镜片	AQL=1.0	8 X放大镜	生产全检项目
3	螺纹胶	AQL=1.0	8 X放大镜	生产全检项目
4	密封胶	AQL=1.0	8 X放大镜	生产全检项目
5	FPC	AQL=1.0	4 5X显微镜（连续变焦）	生产全检项目
6	连接器	AQL=1.0	4 5X显微镜（连续变焦）	生产全检项目
7	补强钢板	AQL=1.0	目视	生产全检项目
外型尺寸				
1	高度	AQL=1.0	与生产相同	生产全检项目
2	长度	AQL=1.0	与生产相同	生产全检项目
3	宽度	AQL=1.0	与生产相同	生产全检项目
4	螺纹扭力	每批N=5, C=0	扭力搬手	QA抽检项目
5	底座推力	每批N=5, C=0	推力计	QA抽检项目

8. Reliability Specification (可靠性)

序号	测试项目	条件及要求	试验设备
1	高低温运行	在低温-20℃±2℃， 保持24H → 高温 70℃±2℃ ， 保持24H	高低温箱
2	高低温贮存	低温-40℃±2℃， 保持48H → 高温70℃±2℃， 保持48H	高低温箱
3	振动试验	A) 振动频率为： 5Hz-20Hz， 20Hz-500Hz; B) 振动加速度谱密度为： 0.96m2/s3， 0.96m2/s3， 其它-3db/倍频; C) 振动持续时间： 60min±0.5min/轴， 共有X/Y/Z 三轴， 振动的振幅为2mm	振动试验台
4	跌落试验	高度1.5m,负载200g,逐步对六个面分别进行跌落， 每个面跌3次	跌落架
5	工作寿命试验	试样装上测试主板， 测试的总时间为9 天(216 小时) 1) 第一天 (24 小时)每2 小时进行一次功能测试2) 第二天 (25~48小时)每4 小时进行一次功能测试; 3)第三天以后(49~216小时)每8~12 小时进行一次功能测试	度信测试主板
6	ESD 实验	将样品放到测试台上,对Lens 上表面进行±8KV的接触放电和±12KV 的空气放电,正负电压各放电10 次,每秒1 次.前后两次放电时间间隔1 秒	静电放电抗扰仪
7	FPC 弯折实验	折迭FPC 正面到反面,弯折角度为90 度， 一共做50 次	手动弯折
8	连接器插拔试验	插拔的总次数为50 次,每插拔10 次进行一次功能测试	手动插拔
9	冷热冲击试验	1) 在-40℃±2 ℃的低温环境下保持1H; 2) 在85℃±2℃ 的高温环境下保持1 H;3)中间转换温度时间不超过10min， 共做25 个循环	高低温箱
10	镜头推力试验	沿钢片水平方向推镜头， 推力大于等于2 Kgf,保持5S 钟	推拉力计
11	盐雾试验	在试验箱35℃±2℃环境， 饱和桶温度47℃±2℃ 的密闭环境中， 湿度大于85%RH, PH 值在6.5~7.2 范围内， 用5%±1 %的 NaCl 溶液连续48H 盐水喷射	盐雾实验机

9.样品出货检验报告

NO.	检验项目	检验方法	检验规格	检测结果		(ACC/REJ)
1	外观	目视	参考成品检验规范	OK		Accept
2	尺寸 (Unit:mm)	□游标卡尺	8.5mm*8.5mm*5.1mm	Max:	5.3mm	Accept
				Min:	4.9mm	Accept
		□游标卡尺	6.5mm*6.5mm*4.1mm	Max:	4.3mm	Accept
				Min:	4.1mm	Accept
		□高度量测仪		Max:		Accept
				Min:		Accept
3	影像	目视	脏点,脏污,鬼影,打不开,模糊	OK		Accept
4	外观	目视	镜头脏点,脏污,FPC 金手指断,漏贴保护膜,海棉胶	OK		Accept
5	包装	目视	包装无破损,短装,Lable标识清楚正确	OK		Accept
6	出货地址	目视	参考出货通知单或采购合同订单	OK		Accept
7	客户定单编号	目视	参考出货通知单或采购合同订单	OK		Accept
8	其他					
注:检测结果栏若有具体数据须填写数据,则合格填" OK",不合格填"NG"						

FEATURES

120mA output driver with 10-bit resolution DAC
Smart Actuator Control (SAC™) modes
Supply voltage (V_{DD}): 2.3V to 4.3V
I/O voltage (V_{IN}): 1.8V to V_{DD}
Fast mode and Fast mode plus I²C interface compatible
Power On Reset (POR)
Power Down (PD) mode current consumption less than 1uA
Package: 6-pin WLCSP (0.77mm x 1.14mm x 0.30mm)

APPLICATIONS

Mobile camera
Digital still camera
Camcorder
Web camera
Action camera

GENERAL DESCRIPTION

The DW9714P designed for linear control of Voice Coil Motors (VCM). This device is compatible with DW9714P. The DW9714P has a single 10-bit DAC with 120mA output current sink capability. This device features SAC™ mode which can minimize the mechanical vibration and achieve very fast mechanical settling time. The SAC™ is protected by patent and registered trademark of DONGWOON ANATECH.

The DW9714P operates from a single 2.3V to 4.3V supply. The internal DAC is controlled via an I²C serial interface that operates at clock rate up to 1MHz. The I²C address for the DW9714P is 0x18. The DW9714P offers PD mode with current consumption less than 1uA.

The DW9714P can be used for auto focus applications in mobile cameras, digital still cameras, camcorders, web cameras and action cameras.

TYPICAL APPLICATION CIRCUIT

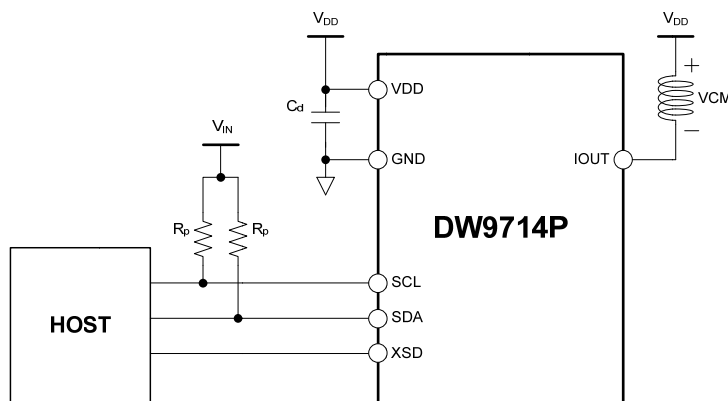


Figure 1. Typical application circuit

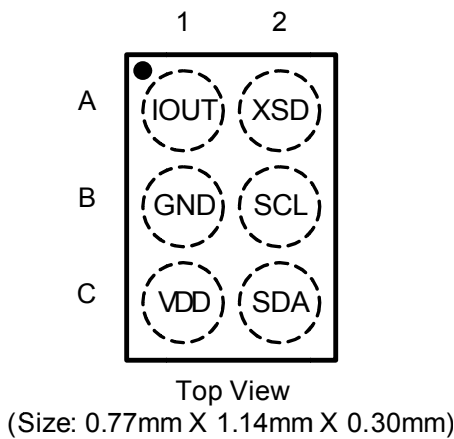
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1 Pin Information

1.1 Pin Assignment and Package Dimension

Table 1.



No.	Pin Name	I/O	Description
A1	IOUT	O	Output current sink
A2	XSD	I	Shutdown mode (active low)
B1	GND	-	Ground
B2	SCL	I	I ² C interface data input/output
C1	VDD	-	Supply voltage
C2	SDA	I/O	I ² C interface clock input

Figure 2. Package dimension

2 Block Diagram

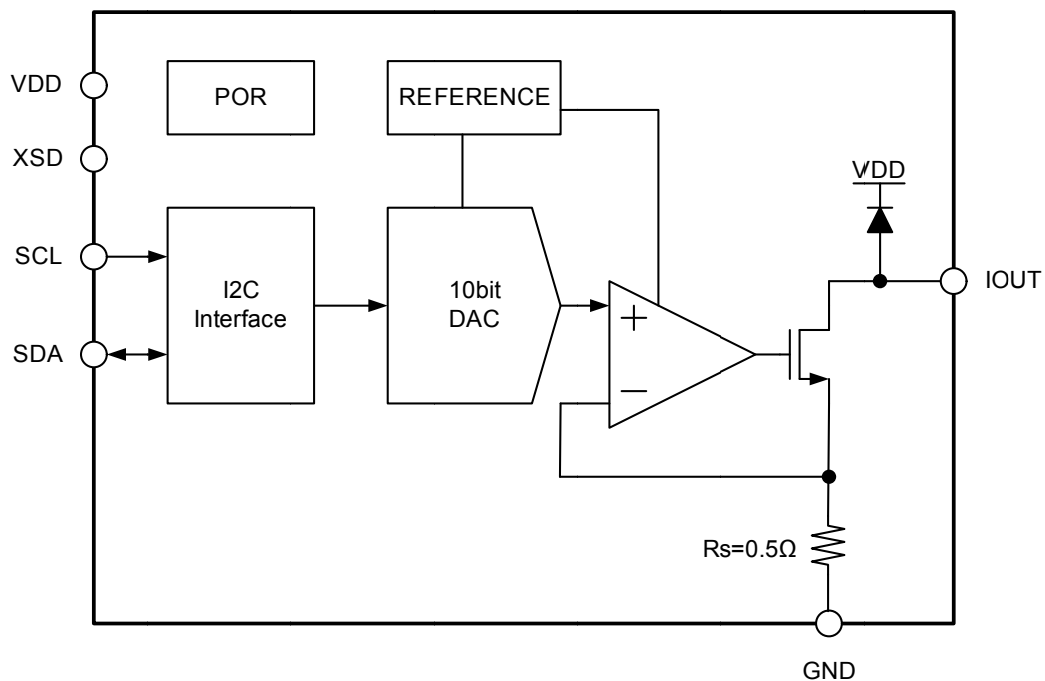


Figure 3. Block Diagram

3 Absolute Maximum Ratings

Table 2.

Symbol	Parameter	Min.	Max.	Unit
V _{DD}	Power supply voltage	-0.3	5.5	V
V _{IN}	Control input voltage	-0.3	5.5	V
T _{OPR}	Operating temperature range	-40	85	°C
T _J	Junction temperature	-	125	°C
T _{STG}	Storage temperature range	-55	150	°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only, functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability

4 Recommended Operating Condition

Table 3.

Symbol	Parameter	Min.	Typ.	Max.	Unit
V _{DD}	Power supply voltage	2.3		4.3	V
V _{IN}	Control input voltage	0		V _{DD}	V
f _{SCL}	Serial clock frequency		400	1000	kHz

5 Electrical Specifications

Table 4. ($V_{DD} = 2.8V$, $V_{IN} = 1.8V$, $T_A = 25^\circ C$, unless otherwise specified)

Characteristic	Symbol	Condition	Min.	Typ.	Max.	Unit
Overall						
Power supply voltage	V_{DD}		2.3		4.3	V
VDD current	I_{SD}	Shutdown mode (XSD = Low)	-1		+1	μA
	I_{PD}	Power down mode (PD = '1')	-1		+1	μA
	I_Q	Quiescent mode (DAC = 0)			0.35	mA
	I_{ACT}	Operation mode (DAC $\neq$ 0)			1	mA
Waiting time	t_{OPR}	After V_{DD} rising	1			ms
Logic Input / Output (XSD)						
Input current		$V_{IN} = 4.3V$	-1		+1	μA
Low level input voltage	V_{IL}	$V_{DD} = 2.8V$			0.54	V
High level input voltage	V_{IH}	$V_{DD} = 2.8V$	1.26			V
Logic Input / Output (SCL, SDA)						
Input current		$V_{IN} = 3.3V$	-1		+1	μA
Low level input voltage	V_{IL}				0.54	V
High level input voltage	V_{IH}		1.26			V
Glitch rejection ⁽¹⁾			50			ns
SDA low level output voltage	V_{OL}	Sink current = 3mA			0.4	V
VCM Driver						
Current resolution				10		bits
INL ⁽¹⁾⁽²⁾	I_{INL}				± 4	LSB
DNL ⁽¹⁾⁽²⁾	I_{DNL}				± 1	LSB
Total output resistance ⁽¹⁾		Output current = 100mA			1.5	Ω
Maximum output current	I_{MAX}		115	120	125	mA
Output current	I_{OUTPD}	Power down mode (PD = '1')	-1		1	μA

⁽¹⁾ These are guaranteed by design and characterization.

⁽²⁾ Linearity is guaranteed for 32code through 992code.

6 I²C Protocol

6.1 Start and Stop Condition

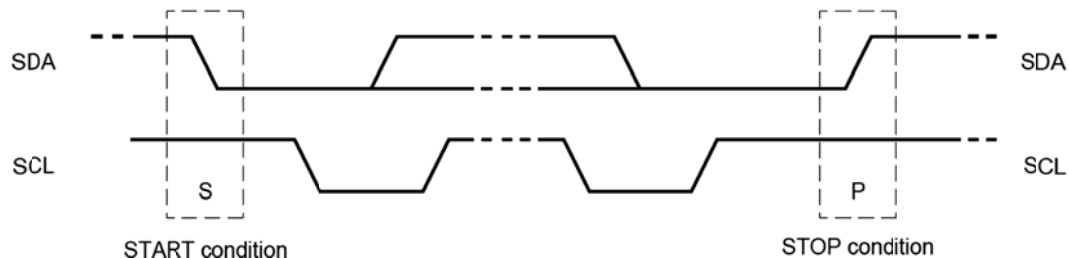


Figure 4. I²C Start and Stop Condition

Within the procedure of the I²C-bus, unique situations arise and are defined as START (S) and STOP (P) conditions. A HIGH to LOW transition on the SDA line while SCL is HIGH is one of such unique cases. This situation indicates a START condition. A LOW to HIGH transition on the SDA line while SCL is HIGH defines a STOP condition.

6.2 I²C Data Transfer

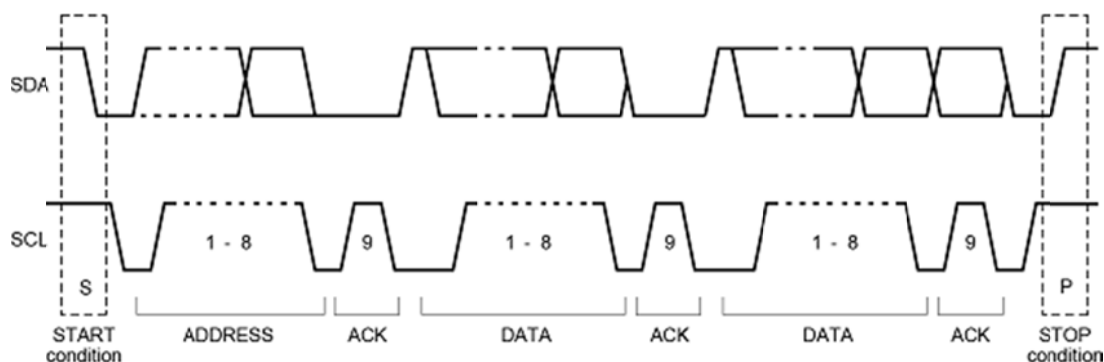


Figure 5. I²C Data transfer

Data transfers follow the above format. After the START condition (S), a slave address is sent. A data transfer is always terminated by a STOP condition (P) generated by the master. However, if the master still needs to communicate on the bus, it can generate a repeated data transfer.

6.3 I²C Timing

Table 5.

Parameter	Symbol	Fast-mode		Fast-mode Plus		Unit
		Min.	Max.	Min.	Max.	
Serial clock frequency	f_{SCL}		400		1000	kHz
Hold time (repeated) START condition.	$t_{HD;STA}$	0.6	-	0.26	-	us
Low period of the SCL clock	t_{LOW}	1.3	-	0.5	-	us
High period of the SCL clock	t_{HIGH}	0.6	-	0.26	-	us
Set-up time for a repeated START condition	$t_{SU;STA}$	0.6	-	0.26	-	us
Data hold time	$t_{HD;DAT}^{(1)}$	0	-	0	-	us
Data set-up time	$t_{SU;DAT}$	100	-	50	-	ns
Rise time of both SDA and SCL signals	t_r	$20+0.1C_b^{(2)}$	300	$20+0.1C_b^{(2)}$	120	ns
Fall time of both SDA and SCL signals	t_f	$20+0.1C_b^{(2)}$	300	$20+0.1C_b^{(2)}$	120	ns
Set-up time for STOP condition	$t_{SU;STO}$	0.6	-	0.26	-	us
Bus free time between a STOP and START condition	t_{BUF}	1.3	-	0.5	-	us
Capacitive load for each bus line	C_b	-	400	-	550	pF
Pulse width of spike suppress	t_{SP}	0	50	0	50	ns
Data valid time ⁽³⁾	$t_{VD;DAT}$	-	0.9	-	0.45	us
Data valid acknowledge time ⁽⁴⁾	$t_{VD;ACK}$	-	0.9	-	0.45	us
Noise margin at the LOW level	V_{nL}	$0.1V_{DD}$	-	$0.1V_{DD}$		V
Noise margin at the HIGH level	V_{nH}	$0.2V_{DD}$	-	$0.2V_{DD}$		V

⁽¹⁾ A master device must provide a hold time of at least 300ns for the SDA signal (with respect to the $V_{IH(MIN)}$ of the SCL signal) to bridge the undefined region of the falling edge of SCL. The maximum data hold time ($t_{HD;DAT}$) has only to be met if the device does not stretch the LOW period (t_{LOW}) of the SCL signal.

⁽²⁾ C_b is the total capacitance of one bus line in pF. t_r and t_f are measured between $0.3xV_{DD}$ and $0.7xV_{DD}$.

⁽³⁾ $t_{VD;DAT}$ = time for data signal from SCL LOW to SDA output (HIGH or LOW, depending on which one is worse).

⁽⁴⁾ $t_{VD;ACK}$ = time for Acknowledgement signal from SCL LOW to SDA output (HIGH or LOW, depending on which one is worse).

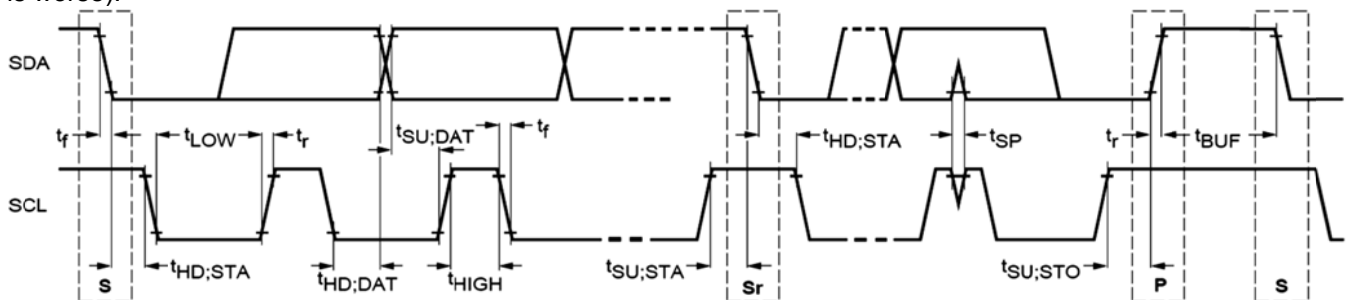


Figure 6. I²C Timing Diagram

7 Operation Mode

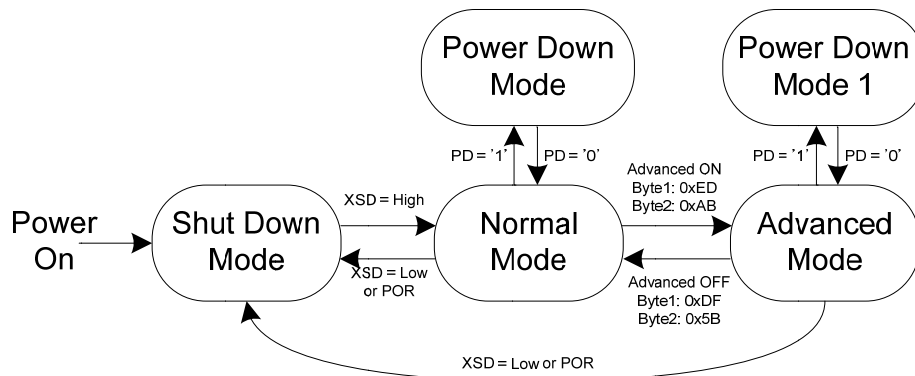


Figure 7. Operation Mode

8 Power Up and Down Sequence

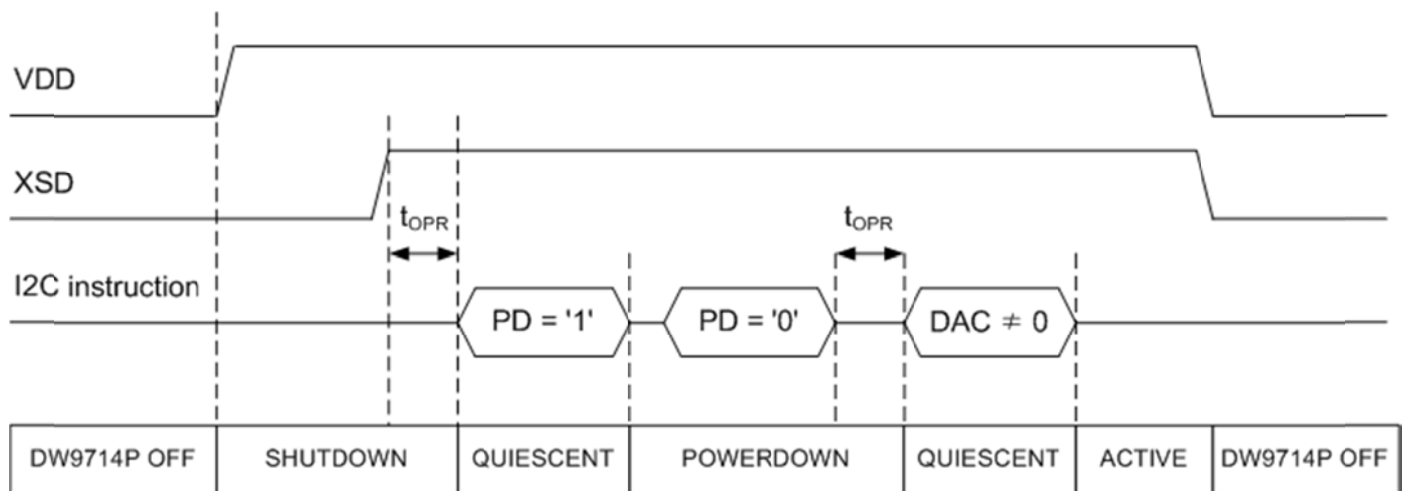


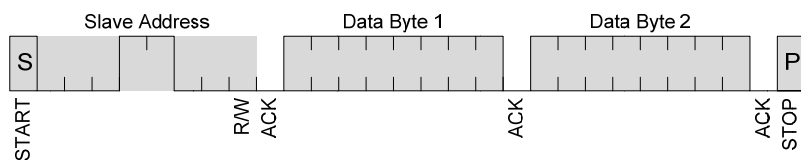
Figure 8. Power Up and Down Sequence

- ※ The sequence of PD = '1' and PD = '0' must be executed after XSD rising.
- ※ Waiting time (t_{OPR}) is needed after XSD rising or PD = '0'.
- ※ XSD must be controlled to "High" or "Low" level. The floating state is not permitted.
- ※ XSD can be connected to VDD.

9 Normal Mode

9.1 I²C Format

■ Write Operation



■ Read Operation

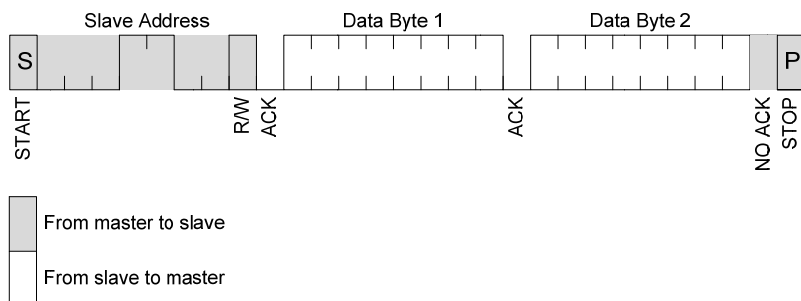


Figure 9. Normal Mode I²C Format

9.2 Register Format

Table 6.

Byte1								Byte2							
PD	FLAG	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	S3	S2	S1	S0

PD: Power down mode

0: Normal operation mode

1: Power down mode (active high)

FLAG: FLAG bit must be checked '0' before Data input (D[9:0]) registers are written.

During LSC or DLC operation, FLAG bit keeps '1'.

While FLAG = '1', the I²C command is ignored.

D[9:0]: Data input

Output current = D[9:0] X (120mA / 1023)

S[3:2]: Codes per step

Table 7.

S[3:2]	Codes per step
00	0 (no SRC) – direct driving
01	1
10	2
11	4

S[1:0]: Step period

Table 8.

S[1:0]	Step period [us]
00	Refer to "LSC time table"
01	Refer to "LSC time table"
10	Refer to "LSC time table"
11	Refer to "LSC time table"

9.3 Slew Rate Control Set up Method

9.3.1 Driving mode – Direct, Linear Slope Control (LSC), Dual Level Control (DLC)

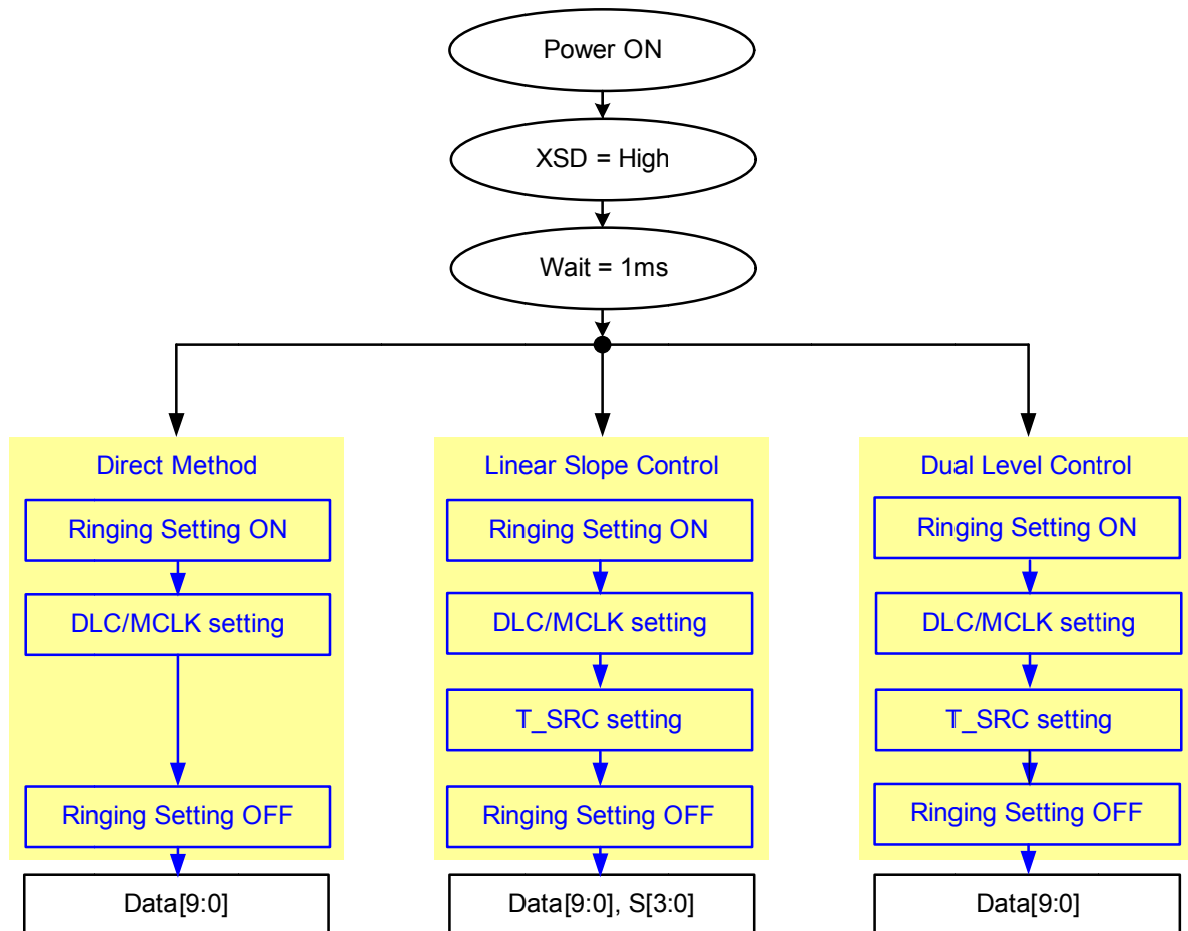


Figure 10. Driving Mode Set up Method

- ※ When use direct mode after power on, it doesn't need register set.
- ※ During a driving mode setting sequence, DAC command does not update.

9.3.2 Direct mode set up method

■ Ringing setting ON

Table 9.

Byte1 (0xEC)								Byte2 (0xA3)							
1	1	1	0	1	1	0	0	1	0	1	0	0	0	1	1

■ DLC and MCLK[1:0] setting

Table 10.

Byte1 (0xA1)								Byte2 (default = 0x05)							
1	0	1	0	0	0	0	1	0	0	0	0	DLC	1	MCLK1	MCLK0

DLC: Dual level control mode

0: Direct and LSC

1: DLC mode

MCLK[1:0]

00: x2 (double) 01: x1 (default)

10: half 11: quarter

■ T_SRC[4:0] setting

Table 11.

Byte1 (0xF2)								Byte2 (default = 0x00)							
1	1	1	1	0	0	1	0	T_SRC4	T_SRC3	T_SRC2	T_SRC1	T_SRC0	0	0	0

■ Ringing setting OFF

Table 12.

Byte1 (0xDC)								Byte2 (0x51)							
1	1	0	1	1	1	0	0	0	1	0	1	0	0	0	1

9.3.3 LSC set up method

■ Ringing setting ON

Table 13.

Byte1 (0xEC)								Byte2 (0xA3)							
1	1	1	0	1	1	0	0	1	0	1	0	0	0	1	1

■ DLC and MCLK[1:0] setting

Table 14.

Byte1 (0xA1)								Byte2 (default = 0x05)							
1	0	1	0	0	0	0	1	0	0	0	0	DLC	1	MCLK1	MCLK0

DLC: Dual level control mode

0: Direct and LSC

1: DLC mode

MCLK[1:0]

00: x2 (double) 01: x1 (default)

10: half 11: quarter

■ T_SRC[4:0] setting

Table 15.

Byte1 (0xF2)								Byte2 (default = 0x00)							
1	1	1	1	0	0	1	0	T_SRC4	T_SRC3	T_SRC2	T_SRC1	T_SRC0	0	0	0

■ Ringing setting OFF

Table 16.

Byte1 (0xDC)								Byte2 (0x51)							
1	1	0	1	1	1	0	0	0	1	0	1	0	0	0	1

※ During a SRC setting sequence, DAC command does not update.

■ LSC time table

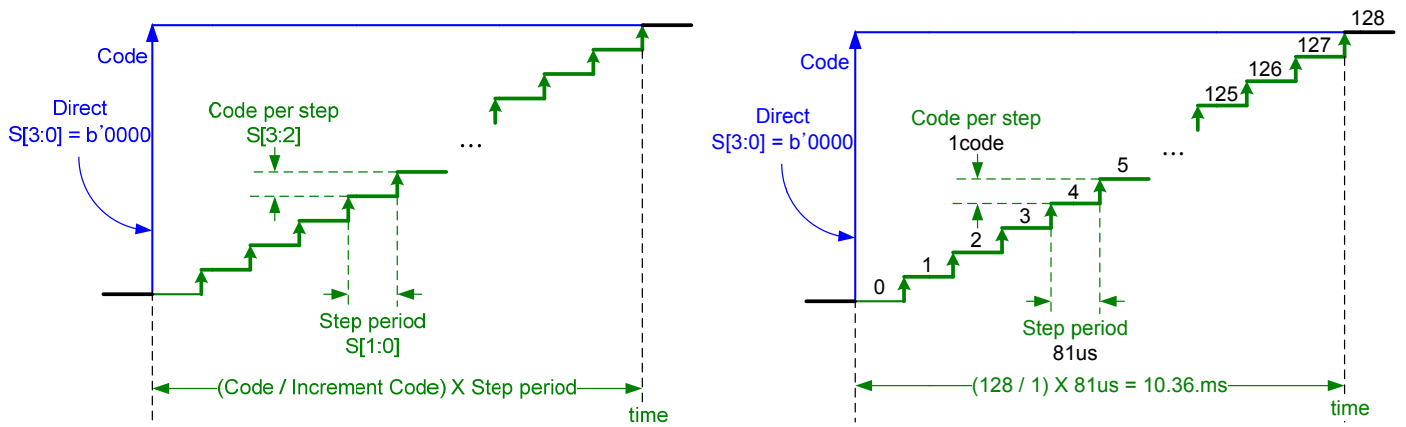
LSC step period is set by S[1:0] and T_SRC[4:0]

Table 17.

Unit: [us]

1 Step period				
T_SRC[4:0]	S[1:0]			
	00	01	10	11
10000	136.0	272.0	544.0	1088.0
10001	130.0	260.0	520.0	1040.0
10010	125.0	250.0	500.0	1000.0
10011	120.0	240.0	480.0	960.0
10100	116.0	232.0	464.0	928.0
10101	112.0	224.0	448.0	896.0
10110	108.0	216.0	432.0	864.0
10111	104.0	208.0	416.0	832.0
11000	101.0	202.0	404.0	808.0
11001	98.0	196.0	392.0	784.0
11010	95.0	190.0	380.0	760.0
11011	92.0	184.0	368.0	736.0
11100	89.0	178.0	356.0	712.0
11101	87.0	174.0	348.0	696.0
11110	85.0	170.0	340.0	680.0
11111	83.0	166.0	332.0	664.0
00000	81.0(default)	162.0	324.0	648.0
00001	79.0	158.0	316.0	632.0
00010	77.5	155.0	310.0	620.0
00011	76.0	152.0	304.0	608.0
00100	74.5	149.0	298.0	596.0
00101	73.0	146.0	292.0	584.0
00110	71.5	143.0	286.0	572.0
00111	70.0	140.0	280.0	560.0
01000	69.0	138.0	276.0	552.0
01001	68.0	136.0	272.0	544.0
01010	67.0	134.0	268.0	536.0
01011	66.0	132.0	264.0	528.0
01100	65.5	131.0	262.0	524.0
01101	65.0	130.0	260.0	520.0
01110	64.5	129.0	258.0	516.0
01111	64.0	128.0	256.0	512.0

■ LSC Scheme



※ 1 step period: Step period $S[1:0] = b'00$, $T_SRC[4:0] = b'0000$, Code per step $S[3:2] = b'01$

Figure 11. LSC Scheme

9.3.4 DLC set up method

■ Ringing setting ON

Table 18.

Byte1 (0xEC)								Byte2 (0xA3)							
1	1	1	0	1	1	0	0	1	0	1	0	0	0	1	1

■ DLC and MCLK[1:0] setting

Table 19.

Byte1 (0xA1)								Byte2 (default = 0x05)							
1	0	1	0	0	0	0	1	0	0	0	0	DLC	1	MCLK1	MCLK0

DLC: Dual level control mode

0: Direct and LSC

1: DLC mode

MCLK[1:0]

00: x2 (double) 01: x1 (default)
10: half 11: quarter

■ T_SRC[4:0] setting

Table 20.

Byte1 (0xF2)								Byte2 (default = 0x00)							
1	1	1	1	0	0	1	0	T_SRC4	T_SRC3	T_SRC2	T_SRC1	T_SRC0	0	0	0

■ Ringing setting OFF

Table 21.

Byte1 (0xDC)								Byte2 (0x51)							
1	1	0	1	1	1	0	0	0	1	0	1	0	0	0	1

※ During a SRC setting sequence, DAC command does not update.

■ DLC time table
Table 22.

Unit: [ms]

T_SRC[4:0]	$t_{VIB}/2$			
	MCLK[1:0]			
	00	01	10	11
10000	21.25	10.63	5.31	2.66
10001	20.31	10.16	5.08	2.54
10010	19.53	9.77	4.88	2.44
10011	18.75	9.38	4.69	2.34
10100	18.13	9.06	4.53	2.27
10101	17.50	8.75	4.38	2.19
10110	16.88	8.44	4.22	2.11
10111	16.25	8.13	4.06	2.03
11000	15.78	7.89	3.95	1.97
11001	15.31	7.66	3.83	1.91
11010	14.84	7.42	3.71	1.86
11011	14.38	7.19	3.59	1.80
11100	13.91	6.95	3.48	1.74
11101	13.59	6.80	3.40	1.70
11110	13.28	6.64	3.32	1.66
11111	12.97	6.48	3.24	1.62
00000	12.66	6.33 (default)	3.16	1.58
00001	12.34	6.17	3.09	1.54
00010	12.11	6.05	3.03	1.51
00011	11.88	5.94	2.97	1.48
00100	11.64	5.82	2.91	1.46
00101	11.41	5.70	2.85	1.43
00110	11.17	5.59	2.79	1.40
00111	10.94	5.47	2.73	1.37
01000	10.78	5.39	2.70	1.35
01001	10.63	5.31	2.66	1.33
01010	10.47	5.23	2.62	1.31
01011	10.31	5.16	2.58	1.29
01100	10.23	5.12	2.56	1.28
01101	10.16	5.08	2.54	1.27
01110	10.08	5.04	2.52	1.26
01111	10.00	5.00	2.50	1.25

※ Recommended that DLC step period is set $t_{VIB}/2$ (t_{VIB} = VCM vibration period)

9.3.5 SRC Test Results

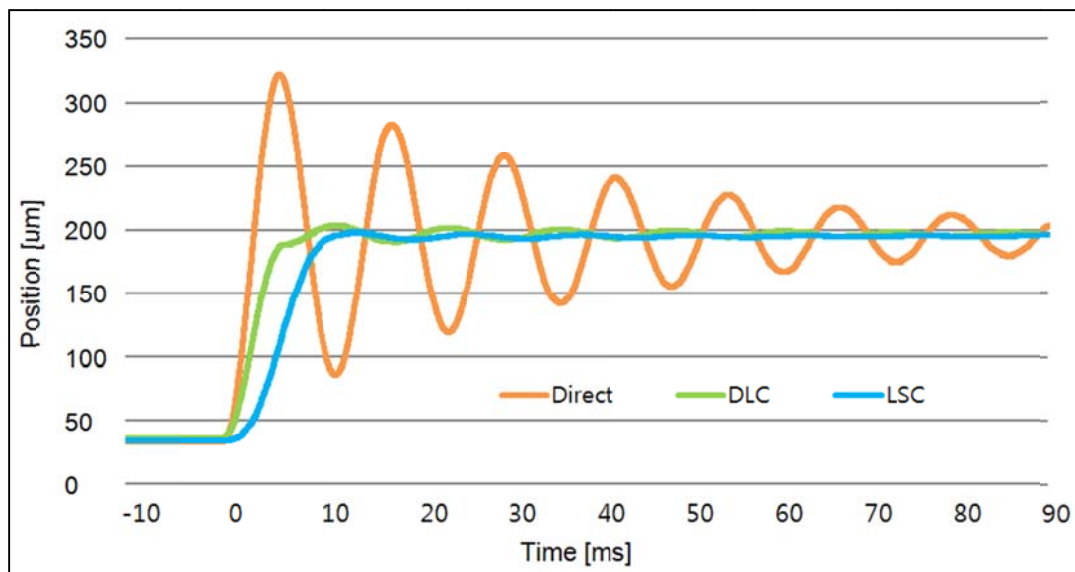


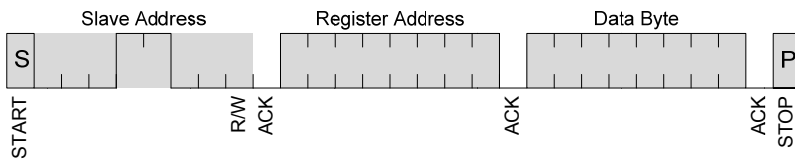
Figure 12. SRC Test Results

10 Advanced Mode

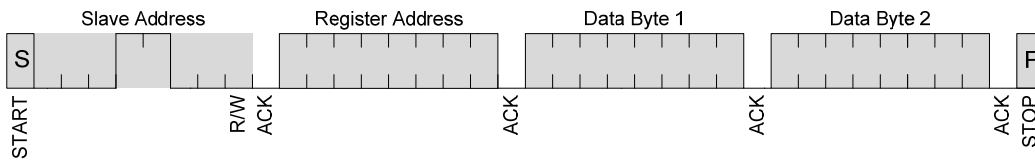
DW9714P is compatible with DW9714P when operating in normal mode. In addition to the normal mode, DW9714P has an advanced mode that includes SAC. It enters its advanced mode by writing 0xED, 0xAB sequentially. When it is in its advanced mode, it can be back to its normal mode by writing 0xDF, 0x5B sequentially. DW9714P supports SAC 2/3/3.5 in its advanced mode.

10.1 I²C Format

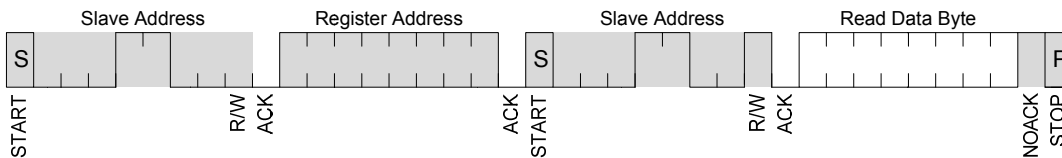
■ Write Operation – Byte Write



■ Write Operation – Sequential Write



■ Read Operation – Selective Read



■ Read Operation – Sequential Read

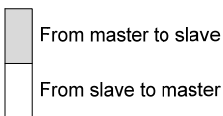
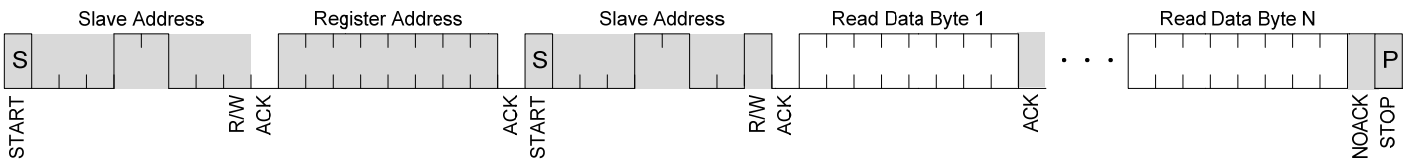


Figure 13. Advanced Mode I²C Format

10.2 Register Map

Table 23.

Name	Addr.	Default	R/W	Data							
				D7	D6	D5	D4	D3	D2	D1	D0
IC INFO	0x00	0xFE	R	IC Manufacturer ID				IC Model			
IC VER.	0x01	-	R					Design Round			
CONTROL	0x02	0x00	R/W								PD
VCM MSB	0x03	0x00	R/W							D9	D8
VCM LSB	0x04	0x00	R/W	D7	D6	D5	D4	D3	D2	D1	D0
STATUS	0x05	0x00	R								BUSY
SAC_CFG	0x06	0x00	R/W	RING_EN	NRC_INFL1	NRC_INFL0	NRC_TIME	SAC_MODE3	SAC_MODE2	SAC_MODE1	SAC_MODE0
PRESC	0x07	0x00	R/W							PRESC1	PRESC0
SACT	0x08	0x00	R/W		SACT6	SACT5	SACT4	SACT3	SACT2	SACT1	SACT0
PRESET	0x09	0x00	R/W	PRESET7	PRESET6	PRESET5	PRESET4	PRESET3	PRESET2	PRESET1	PRESET0
NRC	0x0A	0x00	W							NRC_EN	NRC_MODE

■ IC Information

Table 24.

Name	Addr.	Default	R/W	Data							
				D7	D6	D5	D4	D3	D2	D1	D0
IC INFO	0x00	0xFE	R	IC Manufacturer ID				IC Model			

■ IC Version

Table 25.

Name	Addr.	Default	R/W	Data							
				D7	D6	D5	D4	D3	D2	D1	D0
IC VER.	0x01	-	R					Design Round			

■ Control

Table 26.

Name	Addr.	Default	R/W	Data							
				D7	D6	D5	D4	D3	D2	D1	D0
CONTROL	0x02	0x00	R/W								PD

PD: Power down mode

0: Normal operation mode

1: Power down mode (active high)

■ VCM MSB & VCM LSB

Table 27.

Name	Addr.	Default	R/W	Data							
				D7	D6	D5	D4	D3	D2	D1	D0
VCM MSB	0x03	0x00	R/W							D9	D8
VCM LSB	0x04	0x00	R/W	D7	D6	D5	D4	D3	D2	D1	D0

※ I_{OUT}(DAC output) is updated when address 0x04 is written.

Output current = D[9:0] X (120mA / 1023)

■ Status

Table 28.

Name	Addr.	Default	R/W	Data							
				D7	D6	D5	D4	D3	D2	D1	D0
STATUS	0x05	0x00	R								BUSY

BUSY: Ringing control operation state check

0: Ringing control ending

1: Ringing control operating

■ SAC configuration

Table 29.

Name	Addr.	Default	R/W	Data							
				D7	D6	D5	D4	D3	D2	D1	D0
SAC_CFG	0x06	0x00	R/W	RING_EN	NRC_INFL1	NRC_INFL0	NRC_TIME	SAC_MODE3	SAC_MODE2	SAC_MODE1	SAC_MODE0

RING_EN: Ringing control enable

0: Direct mode

1: Ringing control (LSC, SAC, SLSC)

NRC_INF[1:0]: Noise Reduction Control (NRC) inflection point

Table 30.

NRC_INF[1:0]	Inflection point
00	25.8%
01	33.8%
10	41.9%
11	50.0%

NRC_TIME: NRC operation time

0: 32.11ms

1: 64.22ms

SAC_MODE[3:0]: Ringing control mode

Table 31.

SAC_MODE[3:0]	Ringing control mode	SAC_MODE[3:0]	Ringing control mode
0000	SAC2	0110	LSC Step 1
0100	SAC3	1010	LSC Step 2
1000	SAC3.5	1110	LSC Step 4
0011	SLSC	else	Reserved

※ LSC Step: code per step

■ SAC t_{VIB}

Table 32.

Name	Addr.	Default	R/W	Data							
				D7	D6	D5	D4	D3	D2	D1	D0
PRESC	0x07	0x00	R/W							PRESC1	PRESC0
SACT	0x08	0x00	R/W		SACT6	SACT5	SACT4	SACT3	SACT2	SACT1	SACT0

PRESC[1:0]: Prescaler (SAC period divider)

Table 33.

PRESC[1:0]	SAC period
00	1
01	2
10	4
11	8

SACT[6:0]: SAC time selection

SAC setting time is set by PRESC[1:0] and SACT[6:0] registers and following below equation.

$$\text{SAC setting time} = t_{VIB} = (3.81\text{ms} + (\text{SACT} [6:0]) \times 0.03\text{ms}) \times (\text{PRESC}[1:0])$$

■ Preset

Table 34.

Name	Addr.	Default	R/W	Data							
				D7	D6	D5	D4	D3	D2	D1	D0
PRESET	0x09	0x00	R/W	PRESET7	PRESET6	PRESET5	PRESET4	PRESET3	PRESET2	PRESET1	PRESET0

PRESET[7:0]: NRC current setting

DAC code for preset = { PRESET7, PRESET6,... PRESET1, PRESET0 }

ex) PRESET[7:0] = b'1111 0000 is DAC code for preset = b'1 1110 0000

■ NRC

Table 35.

Name	Addr.	Default	R/W	Data							
				D7	D6	D5	D4	D3	D2	D1	D0
NRC	0x0A	0x00	W							NRC_EN	NRC_MODE

NRC_EN: NRC enable

0: Direct mode

1: NRC

NRC_MODE: NRC setting

0: NRC start

1: NRC landing

10.3 Smart Actuator Control (SAC™)

Mechanical ringing is an inherent problem in VCM. SAC™ is a solution for reducing mechanical ringing and achieving very fast settling time, and as a result, enhances autofocus response times, image quality, and user experience.

SAC™ incorporates a wide band of tolerance around the vibration period of the VCM to compensate for manufacturing variability in the mechanical vibration period (t_{VIB}) of VCM.

DW9714P offers various SAC™ modes which are trade-off between operation time and tolerance. User can choose optimal SAC™ mode for each application.

■ SAC setting Time and Tolerance

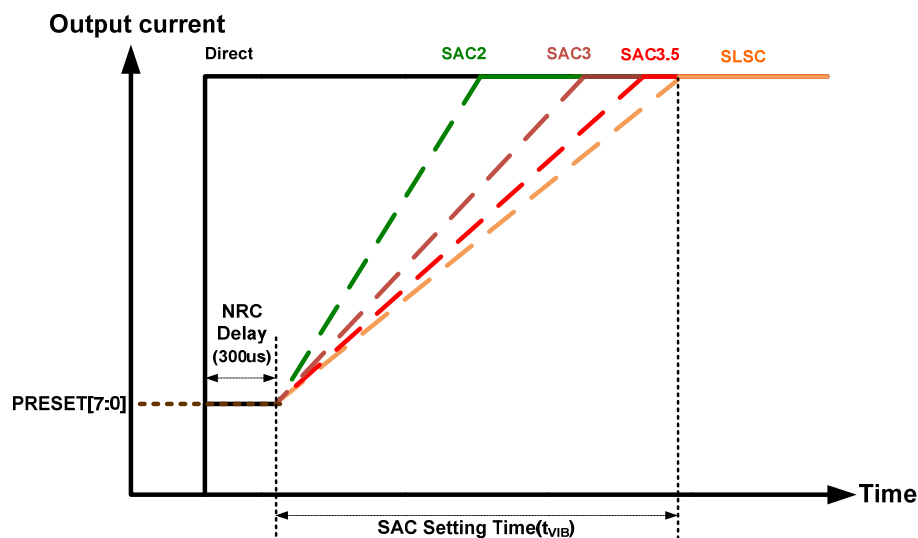


Figure 14. SAC Setting Time

Table 36.

Mode	SAC operation time ⁽¹⁾	Tolerance of VCM ⁽²⁾
Direct	-	-
SAC2	$0.50 \times t_{VIB}$	$\pm 6 \%$
SAC3	$0.75 \times t_{VIB}$	$\pm 16\%$
SAC3.5	$0.92 \times t_{VIB}$	$\pm 24\%$
SLSC	$1.00 \times t_{VIB}$	$\pm 31\%$

⁽¹⁾ The time to reach a target current

⁽²⁾ Tolerance can be changed by mechanical characteristics of specific actuators.

10.4 NRC Start & NRC Landing

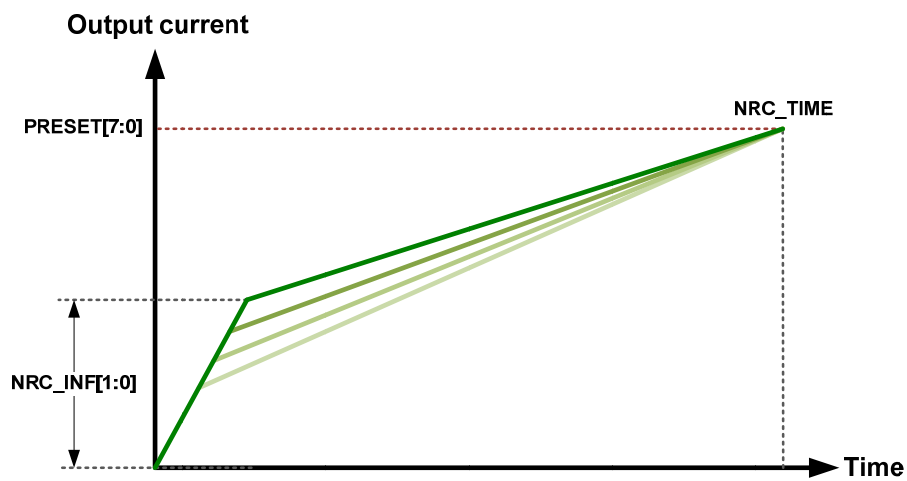


Figure 15. NRC start

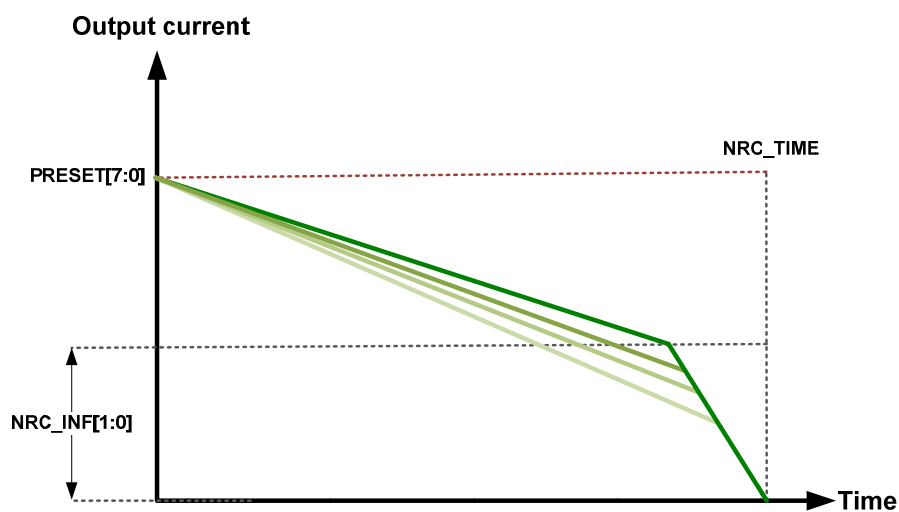


Figure 16. NRC landing

- ※ The NRC start and NRC landing are modes reducing sound noise level from the used VCM application.
- ※ The NRC start and NRC landing algorithm is set by PRESET[7:0] and NRC_TIME, NRC_INF[1:0].
- ※ PRESET[7:0] is NRC current setting.
- ※ NRC_INF[1:0] is NRC Inflection point setting (25~50%).

11 Typical Application Circuit

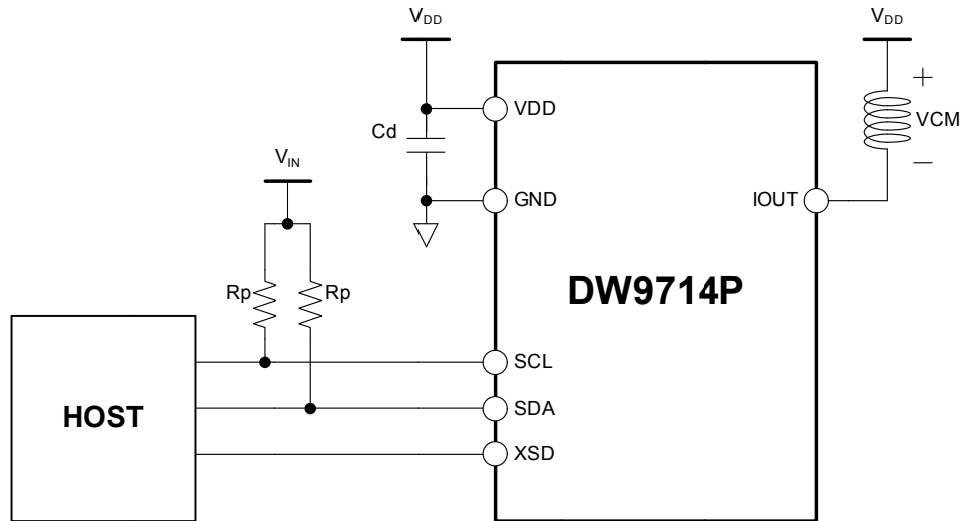
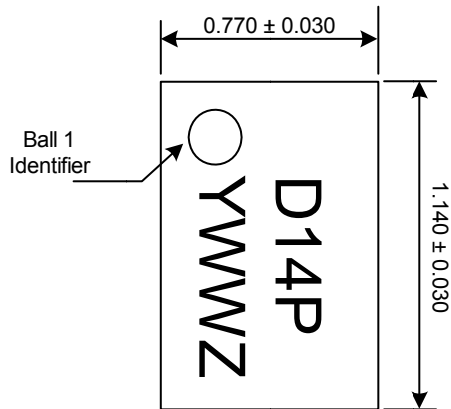


Figure 17. Typical Application Circuit

- ※ Power supply decoupling capacitor (Cd) must be placed as close to the VDD and GND as possible.
- ※ The value of Cd is recommended more than 1uF.
- ※ Recommend resistor (Rp) value is 1.2kΩ ~ 4.7kΩ @ (VIN = 1.8V)
- ※ PCB pattern of VDD, GND and IOUT must be as short and wide as possible.
- ※ XSD must be controlled by GPIO. Otherwise they can be connected to VDD.

12 Package Dimension



NO	NAME	I/O
A1	IOOUT	O
A2	XSD	I
B1	GND	-
B2	SCL	I
C1	VDD	-
C2	SDA	I/O

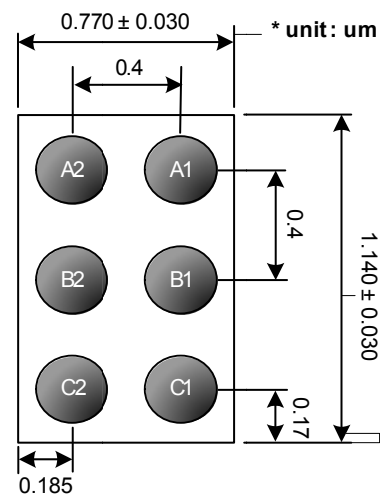
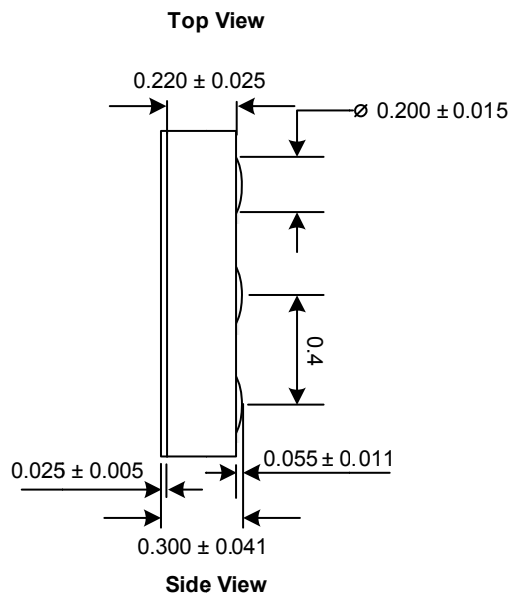


Figure 18. Package Dimension